

General Description

The Sanrise SRC60R030FBS is a high voltage power MOSFET, fabricated using advanced super junction technology. The resulting device has extremely low on resistance, low gate charge and fast switching time, making it especially suitable for applications which require superior power density and outstanding efficiency.

The SRC60R030FBS break down voltage is 600V and it has a high rugged avalanche characteristics.

The SRC60R030FBS is available in TO-247 package.

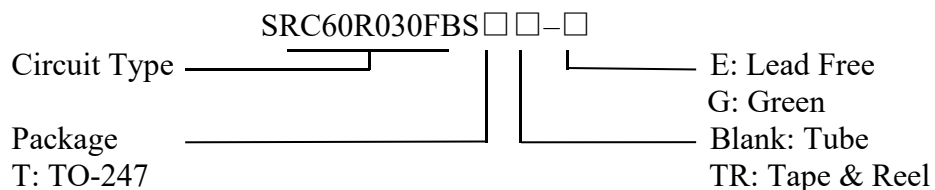
Features

- Ultra Low $R_{DS(ON)} = 30m\Omega @ V_{GS} = 10V$.
- $V_{ds@T_{jmax}} = 650v$.
- Ultra Low Gate Charge, $Q_g = 187nC$ typ.
- Fast switching capability
- Robust design with better EAS performance
- Low Q_{rr}
- Non-automotive Qualified
- Ultra-fast body diode

Application

- High Performance Application
- High Power Application
- EV Charger

Ordering Information



Symbol

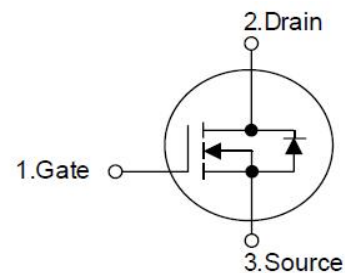


Figure 1 Symbol of SRC60R030FBS

Package Type

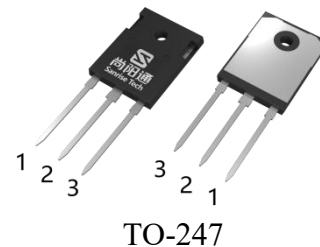


Figure 2 Package Type of SRC60R030FBS

Package	Part Number	Marking ID	Packing Type
TO-247	SRC60R030FBST-G	SRC60R030FBSTG	Tube

Absolute Maximum Ratings^{Note 1}

Parameter		Symbol	Rating	Unit
Drain-Source Voltage		V_{DSS}	600	V
Gate-Source Voltage (static)		V_{GSS}	±20	V
Gate-Source Voltage (dynamic), AC ($f > 1$ Hz)		V_{GSS}	±30	V
Power Dissipation($T_C=25^{\circ}C, TO-247$)		P_{tot}	500	W
Continuous Drain Current	$T_C=25^{\circ}C$	I_D	91	A
	$T_C=100^{\circ}C$		57	
	$T_C=125^{\circ}C$		41	
Pulsed Drain Current (Note 2)		I_{DM}	273	A
Avalanche Energy, Single Pulse (Note 3)		E_{AS}	200	mJ
Avalanche Energy, Single Pulse (Note 4)		E_{AS}	1889	mJ
Avalanche Energy, Repetitive (Note 2)		E_{AR}	1.0	mJ
Avalanche Current, Repetitive (Note 2)		I_{AR}	6.4	A
Continuous Diode Forward Current		I_S	91	A
Diode Pulse Current		$I_{S,PULSE}$	273	A
MOSFET dv/dt Ruggedness, $V_{DS} \leq 480V$		dv/dt	120	V/ns
Reverse Diode dv/dt, $V_{DS} \leq 480V, I_{SD} \leq I_D$		dv/dt	50	V/ns
Operating Junction Temperature		T_J	150	$^{\circ}C$
Storage Temperature		T_{STG}	-55 to 150	$^{\circ}C$
Lead Temperature (Soldering, 10 sec)		T_{LEAD}	260	$^{\circ}C$

Note:

1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.
2. Repetitive Rating: Pulse width limited by maximum junction temperature
3. $I_{AS}=6.4A, V_{DD}=60V, R_G=25\Omega$, Starting $T_J=25^{\circ}C$. Finish goods test condition.
4. $I_{AS}=19.4A, V_{DD}=60V, R_G=25\Omega$, Starting $T_J=25^{\circ}C$. Typical Eas.

Thermal characteristics

Parameter		Symbol	Min	Typ	Max	Unit
Thermal resistance, Junction-to-Case	TO-247	R_{thJC}			0.25	$^{\circ}C/W$
Thermal resistance, Junction-to-Ambient	TO-247	R_{thJA}			60	$^{\circ}C/W$

Electrical Characteristics
 $T_J = 25^\circ\text{C}$, unless otherwise specified.

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
Statistic Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$V_{GS}=0V, I_D=250\mu A$	600			V
Zero Gate Voltage Drain Current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$			10	μA
Gate-Body Leakage Current	Forward	$I_{GSSF}, V_{GS}=20V, V_{DS}=0V$			100	nA
	Reverse	$I_{GSSR}, V_{GS}=-20V, V_{DS}=0V$			-100	
Gate Threshold Voltage	$V_{GS(TH)}$	$V_{DS}=V_{GS}, I_D=2.2mA$	3.0	4.0	5.0	V
Static Drain-Source On-Resistance	$R_{DS(ON)}$	$V_{GS}=10V, I_D=34A$		23.7	30	mΩ
Gate Resistance	R_G	f=1MHz, Open Drain		1.0		Ω
Dynamic Characteristics						
Input Capacitance	C_{ISS}	$V_{DS}=400V, V_{GS}=0V,$		8.6		nF
Output Capacitance	C_{OSS}	f=100kHz		165		
Effective output capacitance, energy related ^{NOTE5}	$C_{O(er)}$	$V_{GS}=0V,$ $V_{DS}=0\dots 400V$		222		pF
Effective output capacitance, time related ^{NOTE6}	$C_{O(tr)}$			1354		
Turn-on Delay Time	$t_{d(on)}$	$V_{DD}=400V, I_D=34A$ $R_G=3\Omega, V_{GS}=12V$		66		ns
Rise Time	t_r			39		
Turn-off Delay Time	$t_{d(off)}$			103		
Fall Time	t_f			10		
Gate Charge Characteristics						
Gate to Source Charge	Q_{gs}	$V_{DD}=400V, I_D=34A$ $V_{GS}=0$ to 10V		70		nC
Gate to Drain Charge	Q_{gd}			69.5		
Gate Charge Total	Q_g			187		
Gate Plateau Voltage	$V_{plateau}$			6.9		V
Reverse Diode Characteristics						
Drain-Source Diode Forward Voltage	V_{SD}	$V_{GS}=0V, I_{SD}=34A$		0.9	1.1	V
Reverse Recovery Time	t_{rr}	$V_R=400V, I_F=34A$ $dI_F/dt=100A/\mu s$		197		ns
Reverse Recovery Charge	Q_{rr}			2.4		μC
Peak Reverse Recovery Current	I_{rrm}			20		A

Note:

- $C_{O(er)}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 480V
- $C_{O(tr)}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 480 V



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